

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination HAMASAKI ET AL.	
		Examiner Djenane M. Bayard	Art Unit 2141	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0022657	01-2003	Herschberg et al.	455/414
*	B	US-2004/0203593	10-2004	Whelan et al.	455/411
*	C	US-2002/0124007	09-2002	Zhao, Yijun	707/102
*	D	US-2004/0002943	01-2004	Merrill et al.	707/1
*	E	US-2003/0033358	02-2003	Tran et al.	709/203
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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